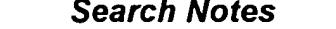


<b>Search Notes</b> 	<b>Application/Control No.</b>  09/761,122	<b>Applicant(s)/Patent under Reexamination</b>  YAMAURA ET AL.
	<b>Examiner</b>  David J. Huisman	<b>Art Unit</b>  2183

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner